

# MOSFET - Power, Single N-Channel

## 40 V, 1.1 mΩ, 240 A

### FDBL9406L-F085

#### Features

- Small Footprint (TOLL) for Compact Design
- Low  $R_{DS(on)}$  to Minimize Conduction Losses
- Low  $Q_G$  and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			$V_{GS}$	$\pm 20$	V
Continuous Drain Current $R_{\theta JC}$ (Notes 1, 3)	Steady State	$T_C = 25^{\circ}\text{C}$	$I_D$	240	A
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_C = 25^{\circ}\text{C}$	$P_D$	300	W
		$T_C = 100^{\circ}\text{C}$		150	
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2, 3)	Steady State	$T_A = 25^{\circ}\text{C}$	$I_D$	43	A
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)		$T_A = 100^{\circ}\text{C}$		31	
		$T_A = 25^{\circ}\text{C}$	$P_D$	3.5	W
		$T_A = 100^{\circ}\text{C}$		1.7	
Pulsed Drain Current	$T_C = 25^{\circ}\text{C}$ , $t_p = 10\text{ }\mu\text{s}$		$I_{DM}$	2755	A
Operating Junction and Storage Temperature Range			$T_J$ , $T_{stg}$	-55 to +175	$^{\circ}\text{C}$
Source Current (Body Diode)			$I_S$	100	A
Single Pulse Drain-to-Source Avalanche Energy ( $I_{L(pk)} = 85\text{ A}$ ; $L = 60\text{ }\mu\text{H}$ )			$E_{AS}$	217	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			$T_L$	260	$^{\circ}\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case – Steady State	$R_{\theta JC}$	0.5	$^\circ\text{C/W}$
Junction-to-Ambient – Steady State (Note 2)	$R_{\theta JA}$	43	

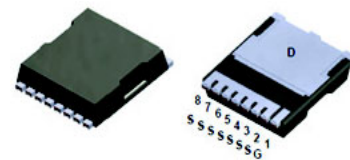
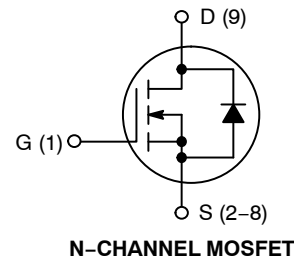
1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Current is limited by bondwire configuration.
2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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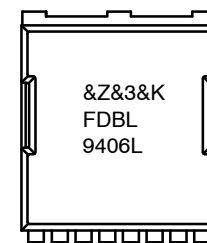
[www.onsemi.com](http://www.onsemi.com)

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ MAX}$	$I_D \text{ MAX}$
40 V	1.1 mΩ @ 10 V	80 A
	1.78 mΩ @ 4.5 V	



MO-299A  
CASE 100CU

#### MARKING DIAGRAM



&Z = Assembly Plant Code  
 &3 = Numeric Date Code  
 &K = Lot Code  
 FDBL9406L = Specific Device Code

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

# FDBL9406L–F085

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	40	–	–	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>		–	19.3	–	mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V, T <sub>J</sub> = 25°C	–	–	1	μA
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V, T <sub>J</sub> = 175°C	–	–	1	mA
Zero Gate Voltage Drain Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V	–	–	±100	nA

### ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	1	1.9	3	V
Threshold Temperature Coefficient	V <sub>GS(th)</sub> /T <sub>J</sub>		–	–6.5	–	mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A	–	0.9	1.1	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 40 A	–	1.25	1.78	

### CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 20 V	–	8600	–	pF
Output Capacitance	C <sub>oss</sub>		–	2380	–	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		–	106	–	pF
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0.5 V, f = 1 MHz	–	2	–	Ω
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 80 A	–	58	–	nC
		V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 80 A	–	121	–	
Threshold Gate Charge	Q <sub>g(th)</sub>	V <sub>GS</sub> = 0 to 1 V	–	7	–	
Gate-to-Source Gate Charge	Q <sub>gs</sub>	V <sub>DD</sub> = 32 V, I <sub>D</sub> = 80 A	–	26	–	
Gate-to-Drain “Miller” Charge	Q <sub>gd</sub>		–	19	–	
Plateau Voltage	V <sub>GP</sub>		–	3.2	–	V

### SWITCHING CHARACTERISTICS

Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 80 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω	–	22	–	ns
Turn-On Rise Time	t <sub>r</sub>		–	22	–	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		–	134	–	ns
Turn-Off Fall Time	t <sub>f</sub>		–	44	–	ns

### DRAIN–SOURCE DIODE CHARACTERISTICS

Source-to-Drain Diode Voltage	V <sub>SD</sub>	I <sub>SD</sub> = 80 A, V <sub>GS</sub> = 0 V	–	0.81	1.25	V
		I <sub>SD</sub> = 40 A, V <sub>GS</sub> = 0 V	–	0.77	1.2	V
Reverse Recovery Time	T <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>SD</sub> /dt = 100 A/μs I <sub>S</sub> = 80 A	–	77	–	ns
Charge Time	t <sub>a</sub>		–	38	–	
Discharge Time	t <sub>b</sub>		–	39	–	
Reverse Recovery Charge	Q <sub>RR</sub>		–	95	–	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

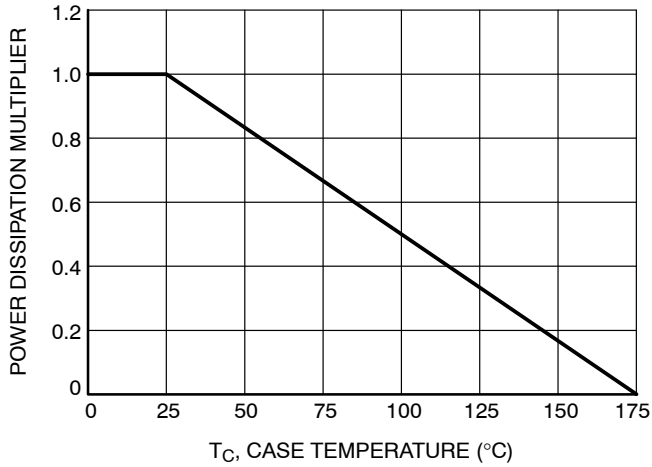


Figure 1. Normalized Power Dissipation vs. Case Temperature

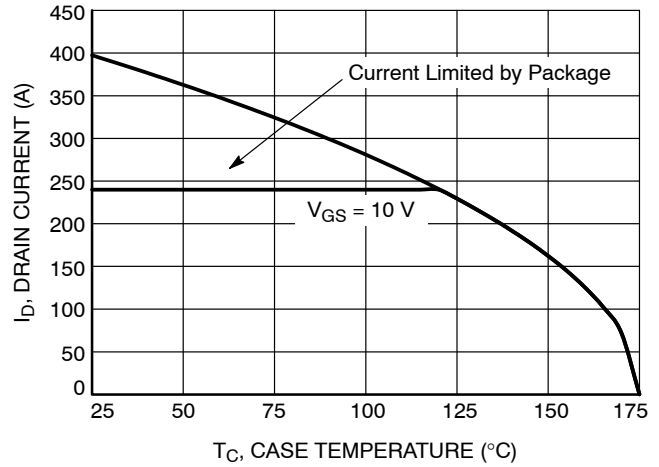


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

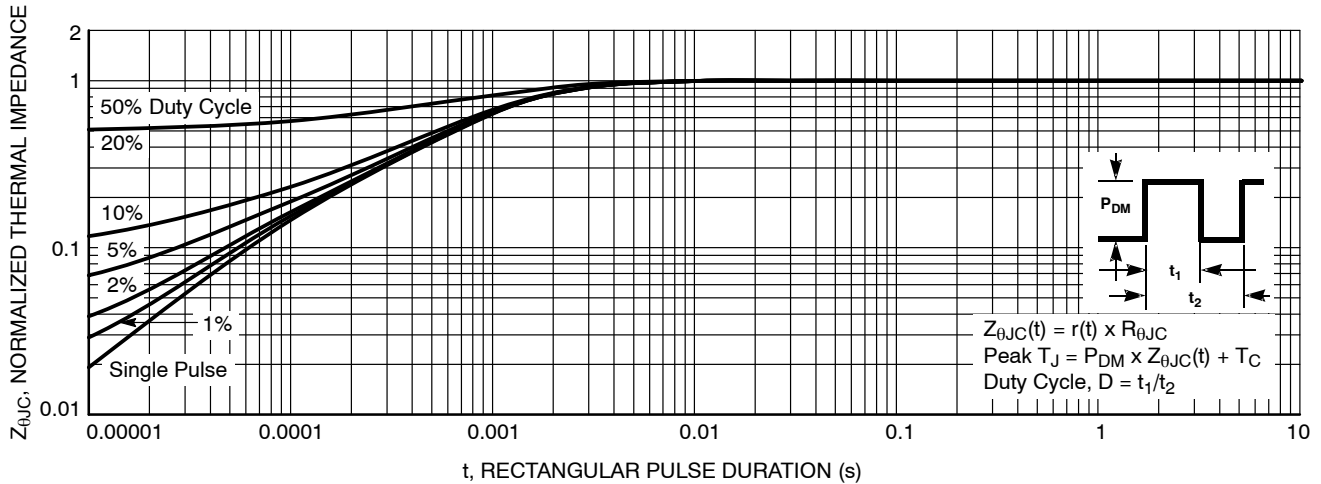


Figure 3. Normalized Maximum Transient Thermal Impedance

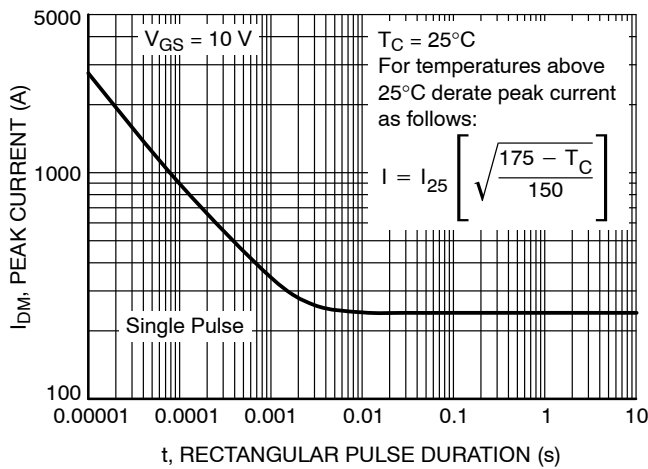


Figure 4. Peak Current Capability

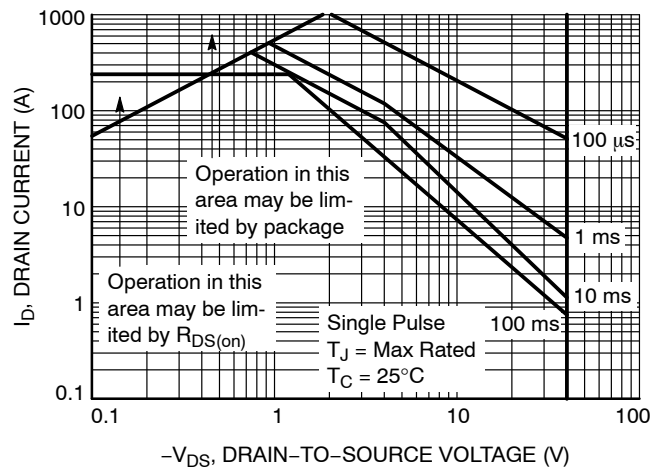
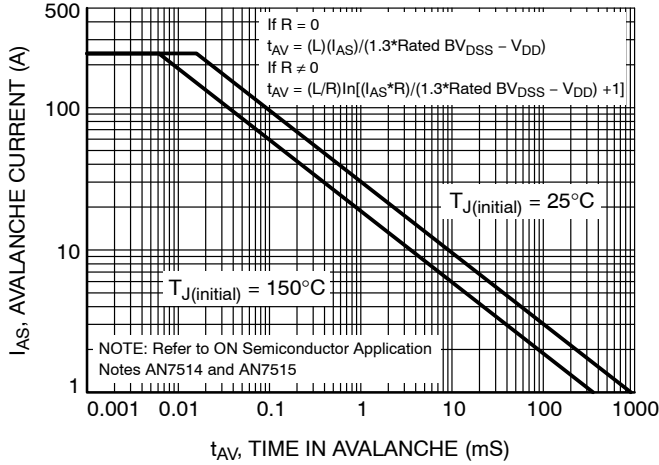
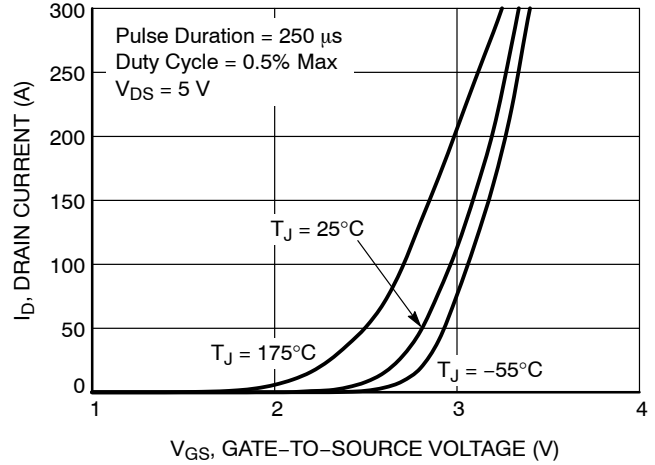


Figure 5. Forward Bias Safe Operating Area

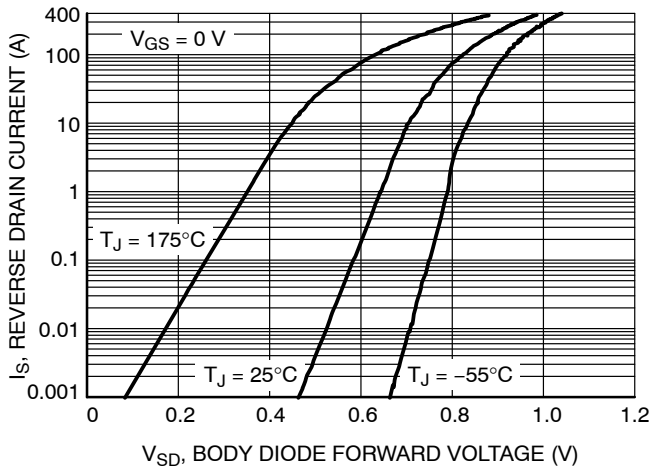
## TYPICAL CHARACTERISTICS



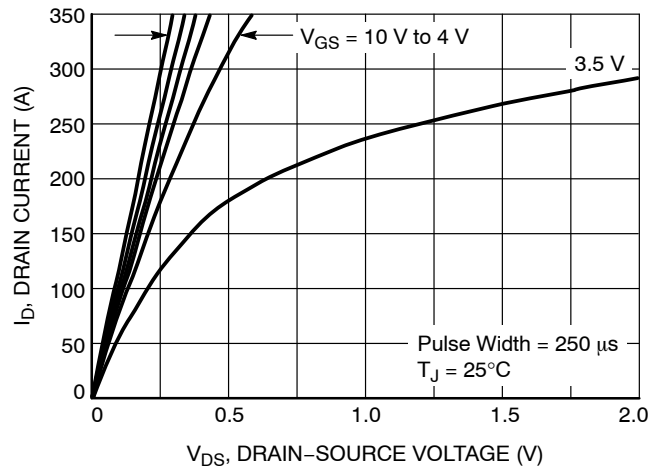
**Figure 6. Unclamped Inductive Switching Capability**



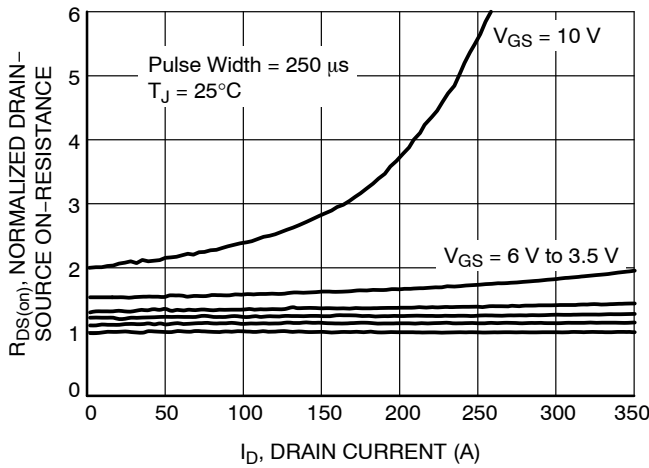
**Figure 7. Transfer Characteristics**



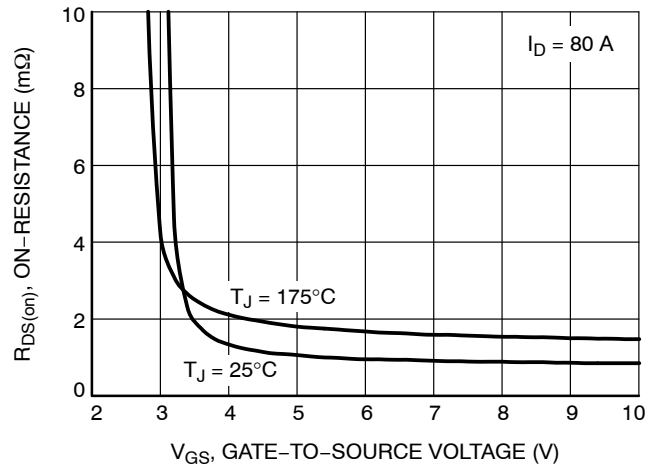
**Figure 8. Forward Diode Characteristics**



**Figure 9. Saturation Characteristics**



**Figure 10. Normalized  $R_{DS(on)}$  vs. Drain Current**



**Figure 11.  $R_{DS(on)}$  vs. Gate Voltage**

TYPICAL CHARACTERISTICS

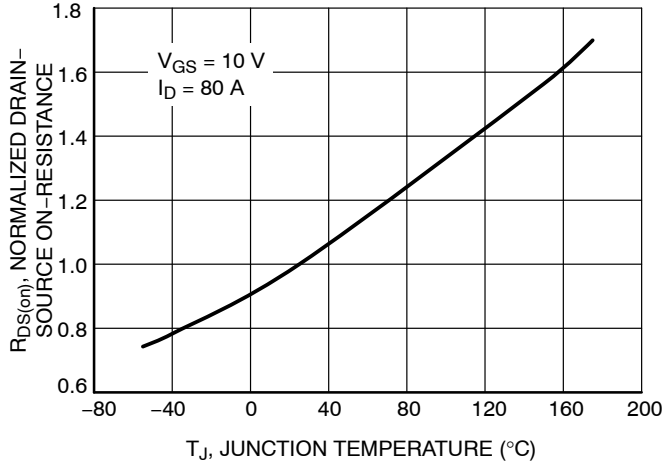


Figure 12. Normalized  $R_{DS(on)}$  vs. Junction Temperature

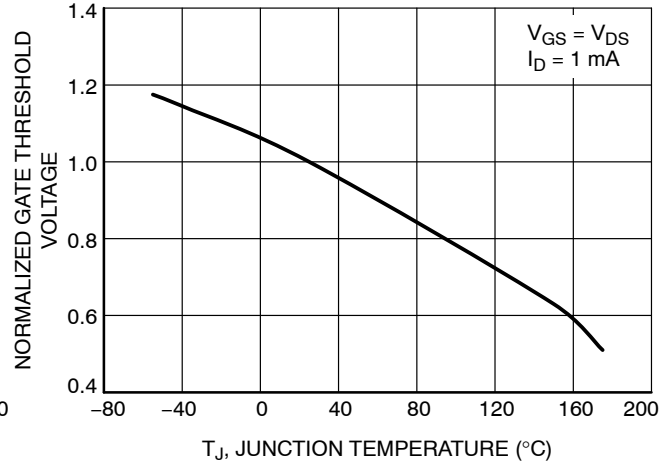


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

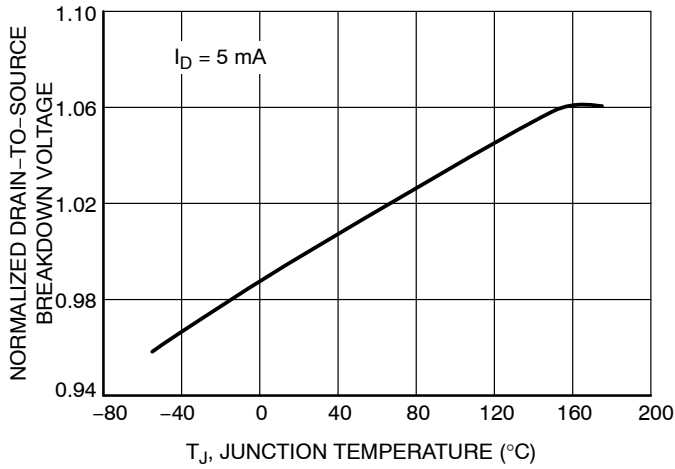


Figure 14. Normalized Drain-to-Source Breakdown Voltage vs. Junction Temperature

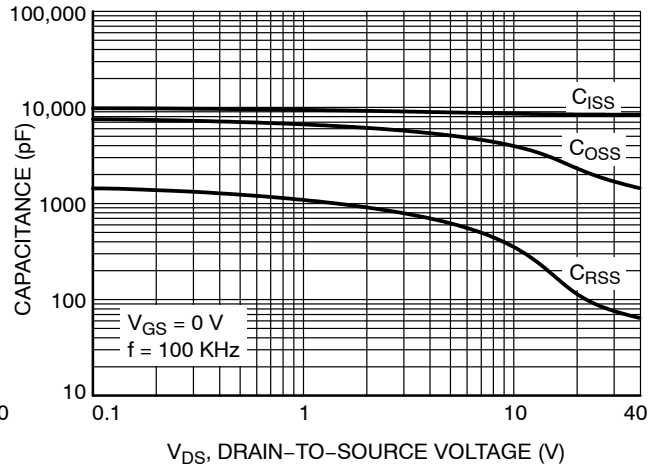


Figure 15. Capacitance vs. Drain-to-Source Voltage

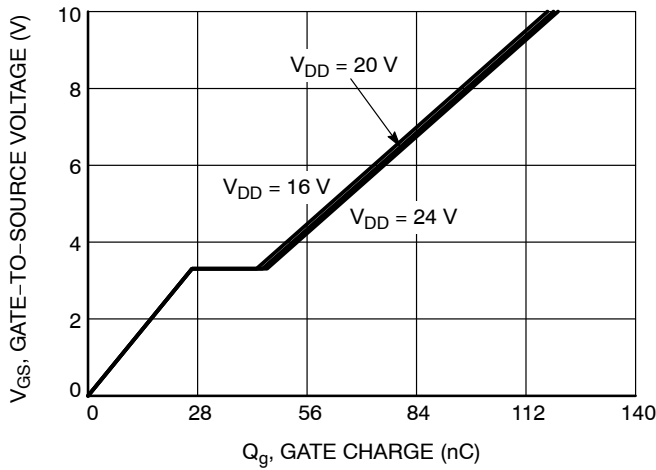
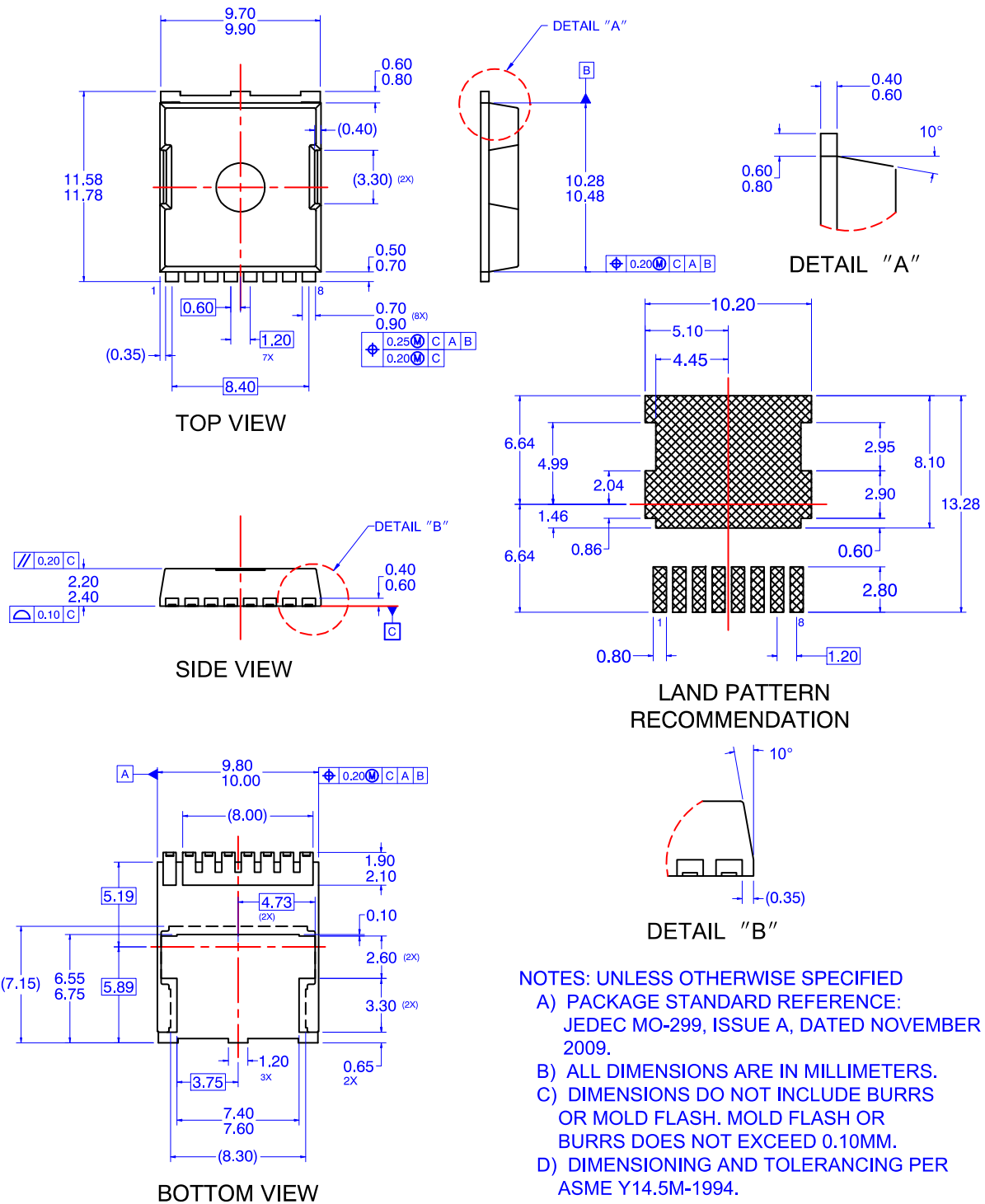


Figure 16. Gate Charge vs. Gate-to-Source Voltage

# FDBL9406L-F085

## PACKAGE DIMENSIONS

H-PSOF8L 11.68x9.80  
CASE 100CU  
ISSUE O




## FDBL9406L–F085

### PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Reel Size	Tape Width	Quantity
FDBL9406L–F085	FDBL9406L	H–PSOF8L (Pb-Free / Halogen Free)	13"	24 mm	2000 Units

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).

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